



# CERTIFICATE OF ACCREDITATION

**ANSI National Accreditation Board**  
11617 Coldwater Road, Fort Wayne, IN 46845 USA

This is to certify that

**Transcat - Ft. Wayne**  
**3020 Congressional Parkway, Suite G**  
**Fort Wayne, IN 46808-4422**

has been assessed by ANAB and meets the requirements of international standard

**ISO/IEC 17025:2017**

and national standard

**ANSI/NCSL Z540-1-1994 (R2002)**

while demonstrating technical competence in the field of

**CALIBRATION**

Refer to the accompanying Scope of Accreditation for information regarding the types of activities to which this accreditation applies

ACT-2489.14  
Certificate Number

  
ANAB Approval

Certificate Valid Through: 09/07/2021  
Version No. 004 Issued: 02/07/2020



This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).

**SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017 AND  
ANSI/NCSL Z540-1-1994 (R2002)**

**Transcat – Ft. Wayne**  
3020 Congressional Parkway, Suite G  
Fort Wayne, IN 46808-4422  
Larry Desormeaux  
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**CALIBRATION**

Valid to: **September 7, 2021**

Certificate Number: **ACT-2489.14**

**Length – Dimensional Metrology**

<b>Parameter/Equipment</b>	<b>Range</b>	<b>Expanded Uncertainty of Measurement (+/-) <sup>2</sup></b>	<b>Reference Standard, Method, and/or Equipment</b>
Angle - Measure Non-contact Contact	0° to 360° 0° to 360°	0.013° 0.011°	Vision System CMM
Micrometers & Calipers – Outside, Inside, Depth, Step	0.01 in to 0.04 in 0.4 in to 1 in 1 in to 4 in 4 in to 15 in 15 in to 40 in	12 μin (13 + 1L) μin (10 + 3.5L) μin (12 + 4L) μin (16 + 4L) μin	Comparison to Gage Blocks
Anvil Flatness	0 in to 1 in Diameter	4.6 μin	Optical Flats
Anvil Parallelism	0 in to 1 in Diameter	8.3 μin	Optical Parallel
Bore Gages	0.125 in to 0.25 in 0.25 in to 1 in 1 in to 6 in	37 μin 39 μin (33 + 7L) μin	Characterized Rings
Digital, Dial, Drop and Test Indicators	0 in to 1 in 1 in to 6 in	(10 + 2L) μin (6 + 5L) μin	Comparison to Gage Blocks
Single Axis – Outside	0 in to 1 in 1 in to 6 in	(6 + L) μin (4.3 + 3.7L) μin	ULM
Thread Wire Sets	2 TPI to 120 TPI 0.00833 to 0.5 in	13 μin	ULM
Sieves Openings Wire Diameters	0.0025 in to 4 in 0.0018 in to 0.315 in	160 μin 160 μin	Vision System ASTM E11 / ISO 3310

**Length – Dimensional Metrology**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-) <sup>2</sup>	Reference Standard, Method, and/or Equipment
Plug Gages – Outer Diameter	0 in to 1 in 1 in to 3 in 3 in to 5 in	15 μin (15 + 2L) μin (11 + 3L) μin	ULM
Pin Gages – Outer Diameter Non-contact	0.004 in to 1 in	33 μin	Laser Micrometer
Ring Gage – Inner Diameter	0.125 in to 0.25 in 0.25 in to 1 in 1 in to 6 in	17 μin (17 + L) μin (17 + 2.5L) μin	ULM
Laser Micrometers	0 in to 1 in	15 μin	Master Pins
Flatness	0 in to 4 in Diameter	4.6 μin	Optical Flat w/ monochromatic Light
Roughness Testers	Ra 12.2 Ra 116.2	4.3 μin 4.5 μin	Precision Reference Standard
Thread Plug Gages Pitch Diameter 60° Thread	0 in to 3 in 3 in to 5 in	80 μin 83 μin	ULM with thread wires
Major Diameter	0 in to 1 in 1 in to 6 in	(6 + L) μin (4.3 + 3.7L) μin	ULM
Thread Ring Gage Inner Pitch Diameter	0 in to 3 in 3 in to 5 in	80 μin 83 μin	Master Plug Uncertainty

**DIMENSIONAL MEASUREMENT**
**1 Dimensional**

Parameter / Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method and/or Equipment
Non-contact X-Y Axis	0 in to 4 in 4 in to 8 in 8 in to 12 in 12 in to 16 in 16 in to 20 in 20 in to 24 in	160 μin 180 μin 200 μin 230 μin 250 μin 280 μin	Vison System



3 Dimensional

Parameter / Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method and/or Equipment
Diagonal (3D) Volumetric	1 in x 1 in x 1 in 3 in x 3 in x 3 in 6 in x 6 in x 6 in 12 in x 12 in x 12 in 24 in x 24 in x 24 in 27 in x 40 in x 27 in	40 μin 270 μin 280μin 290 μin 310 μin 340 μin	CMM

Calibration and Measurement Capability (CMC) is expressed in terms of the measurement parameter, measurement range, expanded uncertainty of measurement and reference standard, method, and/or equipment. The expanded uncertainty of measurement is expressed as the standard uncertainty of the measurement multiplied by a coverage factor of 2 (k=2), corresponding to a confidence level of approximately 95%.

Notes:

1. On-site calibration service is available for this parameter, since on-site conditions are typically more variable than those in the laboratory, larger measurement uncertainties are expected on-site than what is reported on the accredited scope.
2. L = Length in inches.
3. This scope is formatted as part of a single document including Certificate of Accreditation No. ACT-2489.14.



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Vice President

